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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/514,627	KURODA ET AL.	
Examiner	Art Unit	
Fayez G. Assaf	2872	

SEARCHED			
Class	Subclass	Date	Examiner
Updated	previuos notes	10/19/2007	7
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
See	attached	10/19/2007	R	
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